

Electromagnetic compatibility (EMC) —

Part 6-2: Generic standards — Immunity for industrial environments

The European Standard EN 61000-6-2:2005 has the status of a
British Standard

ICS 33.100.20

National foreword

This British Standard is the official English language version of EN 61000-6-2:2005 including corrigendum September 2005. It is identical with IEC 61000-6-2:2005. It supersedes BS EN 61000-6-2:2001 which will be withdrawn on 1 June 2008.

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Summary of pages

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